Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/942,622	SAITO, TAKESHI	
Examiner	Art Unit	
Aung T. Win	2617	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARC (INCLUDING SE	H NOTES ARCH STRATEGY)
	DATE	EXMR
keyword searches	5/23/2006	ATW